

Modulation of electron transport in single layer transition-metal dichalcogenides

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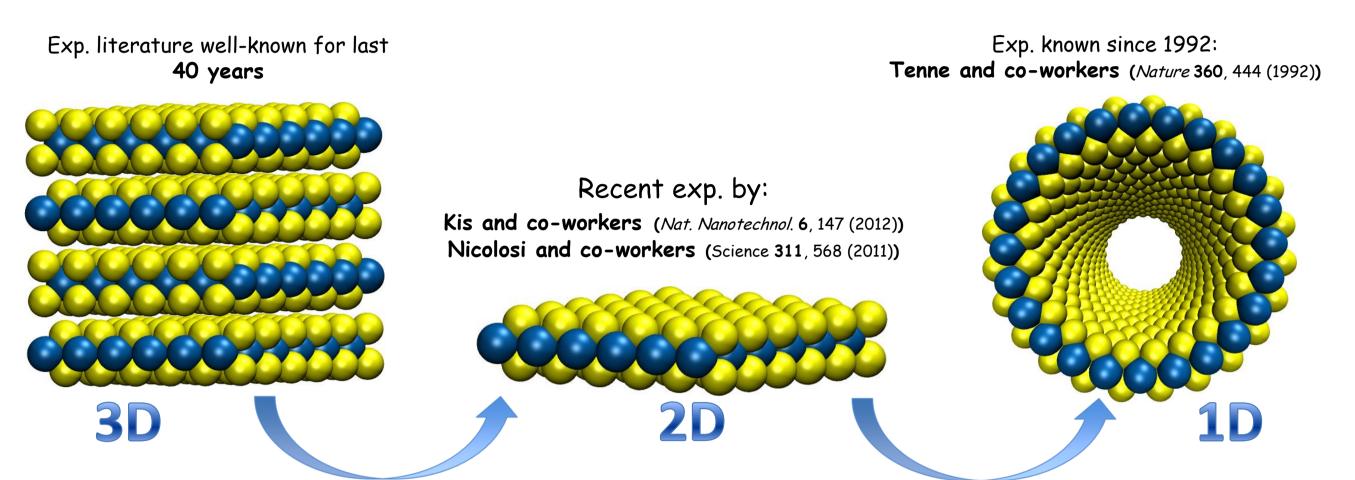
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Abstract

Transition-metal dichalcogenides TX_2 (T=Mo, Nb, Ta, Re, Hf, W and X=Se, S, Te) may become alternatives to carbon based materials in nano-electronics. Recently, a series of electronic devices have been fabricated using a single layer of MoS_2 , presenting promising potential for the next generation electronics. Using density functional based tight-binding (DFTB) method combined with the non-equilibrium Green's function formalism, we have studied electron transport in low-dimensional structures of transition-metal dichalgogenides.



Formalism

Green's function of an extended system

$$\tilde{G}_{C}(E) = \left[ES_{C} - H_{C} - \tilde{S}_{L}(E) - \tilde{S}_{R}(E)\right]^{-1} \qquad \tilde{G}_{L(R)} = i[\tilde{S}_{L(R)} - \tilde{S}_{L(R)}^{+}]$$

Transmission

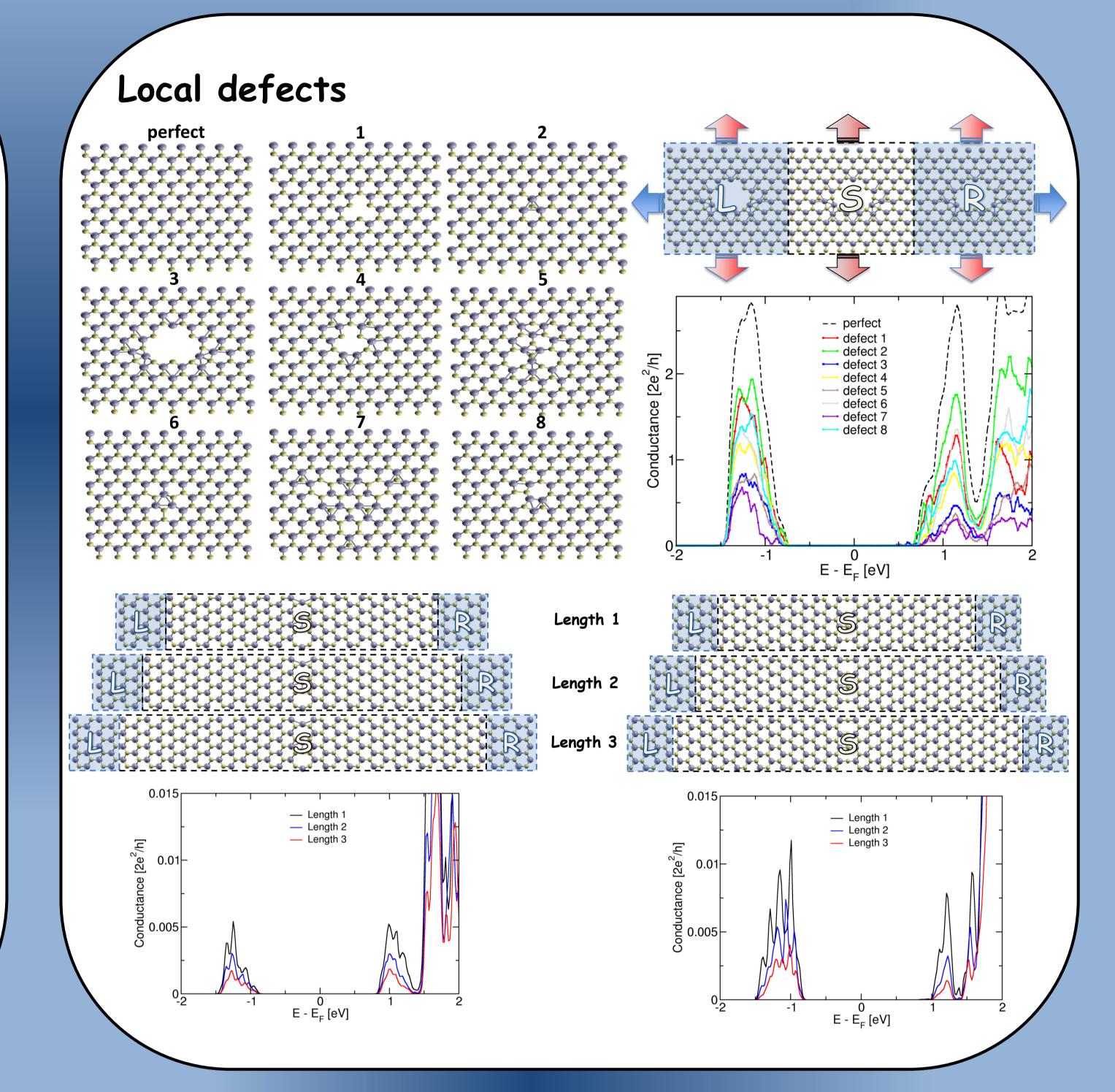
$$T(E) = \sum_{n} T_{n}(E) = Tr \left[\tilde{G}_{C}^{\dagger}(E) \tilde{G}_{R}(E) \tilde{G}_{C}(E) \tilde{G}_{L}(E) \right]$$

Conductance

$$\mathcal{G}(E) = \frac{2e^2}{h}T(E)$$

E - E_F [eV]

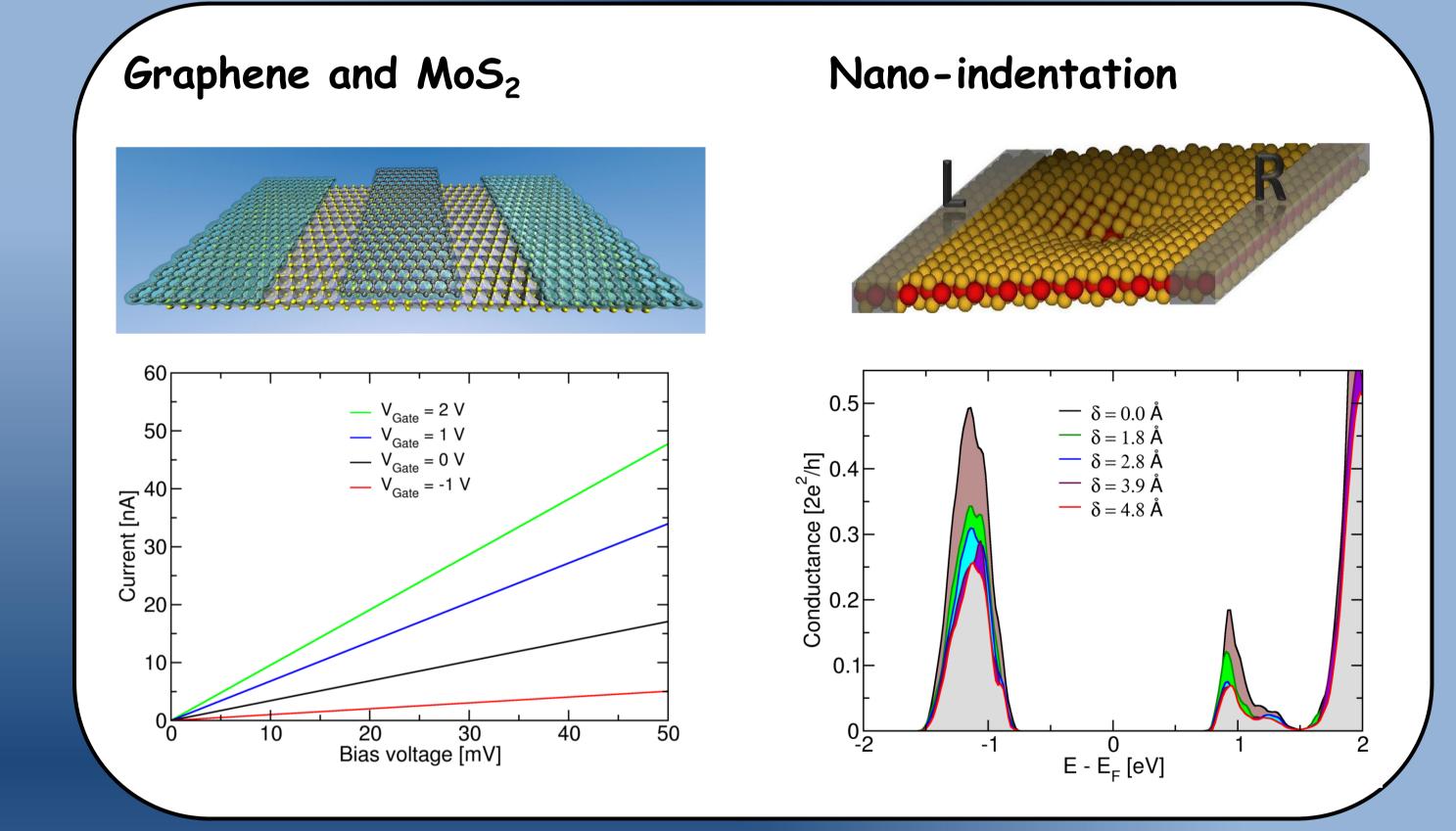
E - E_F [eV]



Isotropic and uni-axial strain b) Isotropic strain MoS_2 3 3.1 3.2 3.3 3.4 3.5 WS_2 2.9 3 3.1 3.2 3.3 3.4 3.5 g [2e²/h] DOS [a. u.] DOS [a. u.] Uni-axial strain Strain-stress relation $\sigma = Y\epsilon$ $Y_{c} = 208$ $R^2 = 0.9999$ = 182 _ ₹ 20 12.6 % 12.6 %

0.04 0.07 0.10 0.13 0.16 0.19

 $\varepsilon = \Delta L/L_0$



Conclusion

- Local defects cause reduction of conductance in MoS_2 monolayer, while the band gap changes only slightly.
- The use of graphene as a metallic electrode for MoS_2 monolayer shows efficient electron injection and ohmic contact through Graphene/ MoS_2 /Graphene junction.
- Tensile strain is a possible way of tuning the band gaps and transport properties of TMD monolayers. The transition semiconductor-metal occurs for elongations as large as 11% for the isotropic strain in MoS_2 monolayer.
- Local deformation due to the indentation process causes a drop of electron conductance, in our model to 60% of its original value. Thus, the electronic structure of single-layer MoS₂ is rather robust upon local deformation.

References

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